

Search Notes**Application/Control No.**

10/777,425

Examiner

Taeyoon Kim

**Applicant(s)/Patent under
Reexamination**

SANBERG ET AL.

Art Unit

1651

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPG-pub;USPAT;USOCR;EPO;JPO;Derwent) – updated search	4/23/2009	TK